mesago

pcim EUROPE

9 - 11.05.2023 NUREMBERG

D³GaN for EV Inverter

Dima Novo VP of R&D VisIC Technologies, Israel

Messe Frankfurt Group



Q: D³GaN – How does VisIC Technologies utilize the benefits of a D-Mode GaN device for high-power application?

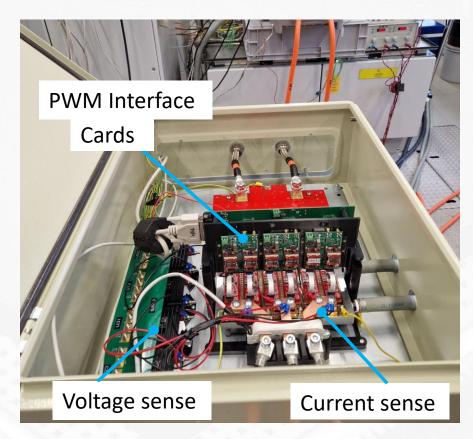
A: D³GaN: Robust & Reliable high-power D-mode device with Direct Drive of the GaN die = Fast switching, low switching losses D-mode Direct Drive GaN

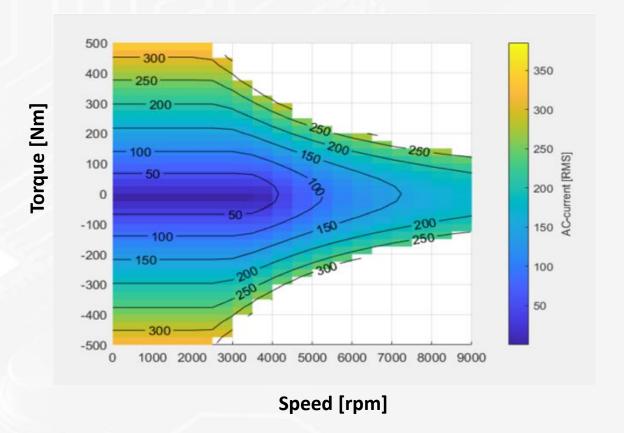
Can a D³GaN device power an EV inverter?



3-Phase D³GaN Inverter, Closed loop DYNO testbench, tested up to 113 kW (El. Pwr)

WLTC Standard (Worldwide harmonized Light-duty vehicles Test Cycle) is a 30 min test for passenger cars and light commercial vehicles mimicking driving cycle



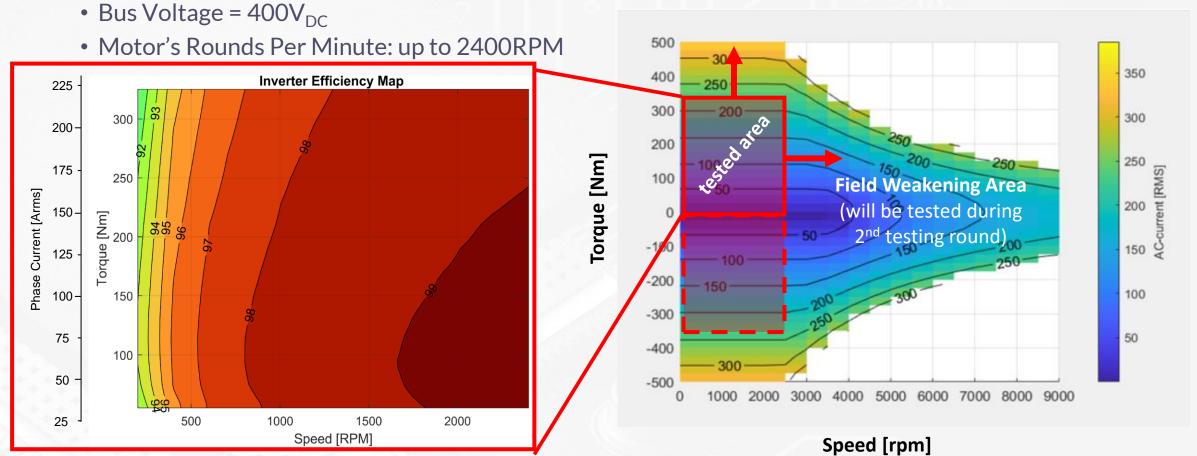


Multiple operation points in the WLTP cycle



3-Phase D³GaN Inverter, Closed loop DYNO testbench:

- 200 points were measured (measurements repeated 3 times) at:
 - Current up to 225A_{RMS}

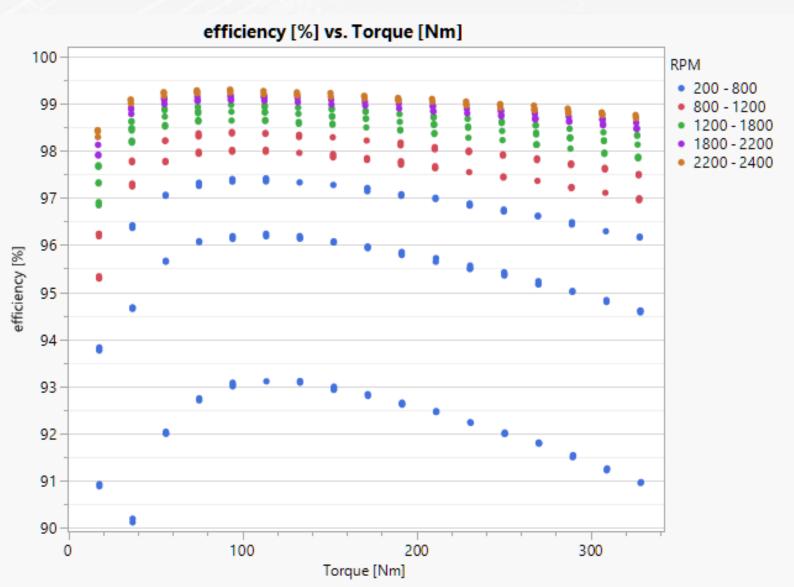


Multiple operation points in the WLTP cycle



Max Efficiency point:

- > 99.295%
- > 2400RPM (120Hz)
- > 92.8Nm
- > 24.4kW output

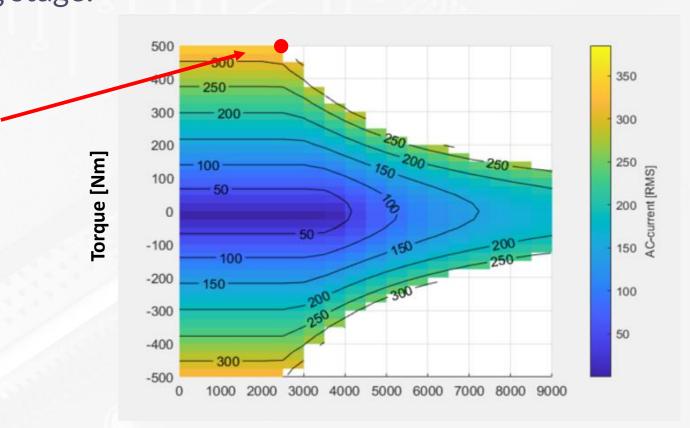


Max power tested during 1st trials



Objective: Testing the system at max parameters defined for this testing stage:

- 400Vbus
- 500Apk/350Arms.ph
- 133Hz (2660rpm)
- 30Sec

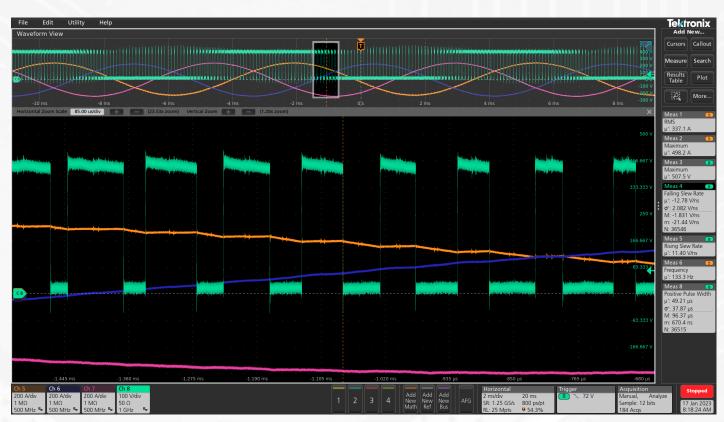


Speed [rpm]

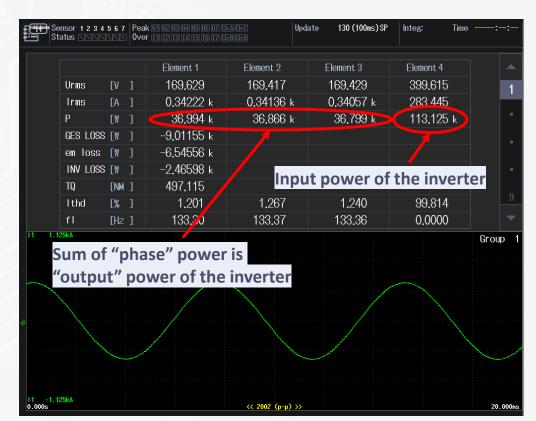
Max power tested during 1st trials



400VDC; Phase current 350Arms/500Apeak; 2660 rpm/133Hz







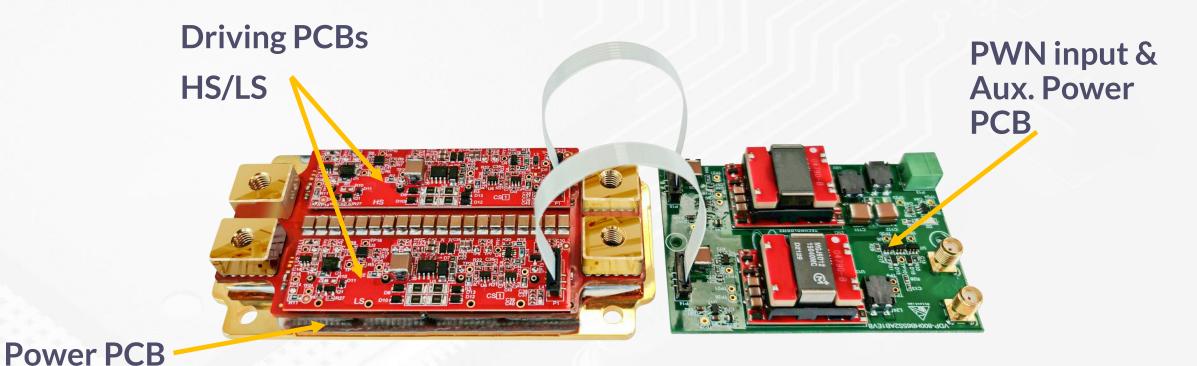
Power meter measurements:

- Element 1/2/3 are measurements of phases 1, 2, 3 correspondingly.
- Element 4 is a measurement of the inverter input

D³GaN Power Module prototype

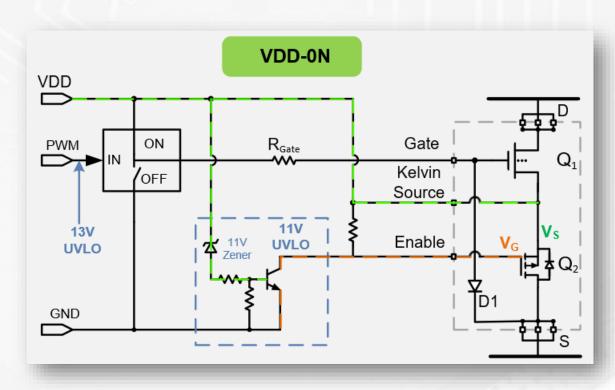


- 4 parallel 8mOhm discrete devices in a HB configuration 2.2mOhm 650V
- Straightforward paralleling of devices
- Off-the-shelf auxiliary components (Gate driver, Aux. power DC/DC, etc.)

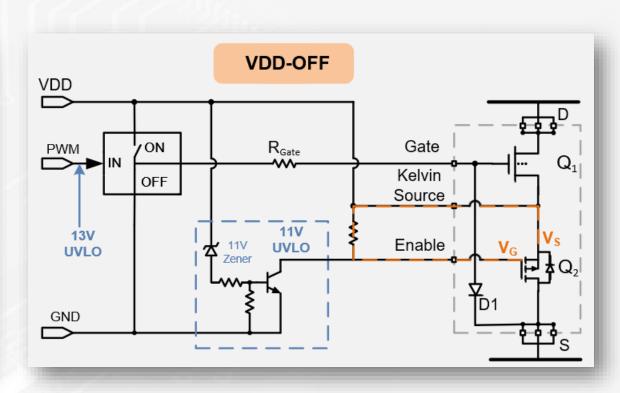


D³GaN – Direct Drive D-Mode GaN pMOS Q2 Operation





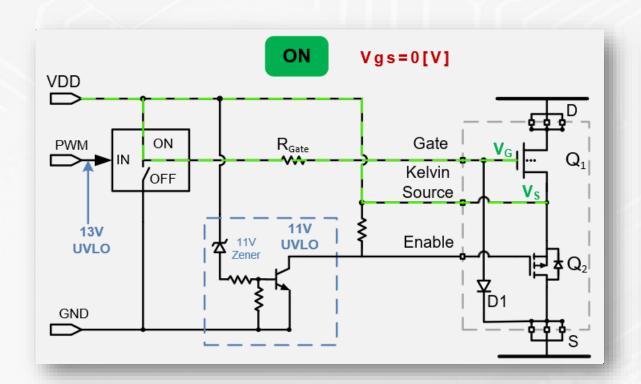


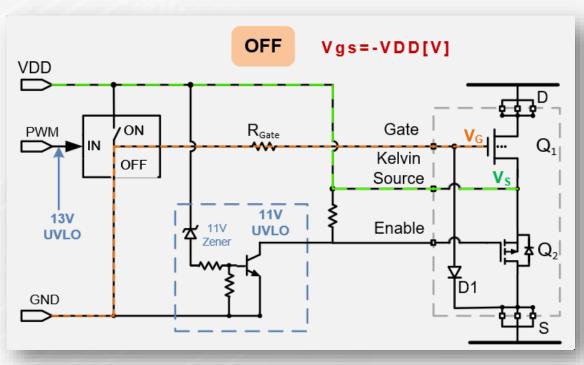


1.
$$V_G = V_S \rightarrow V_{GS} = 0 \rightarrow Q2 \text{ is OFF}$$

D³GaN - Direct Drive D-Mode GaN





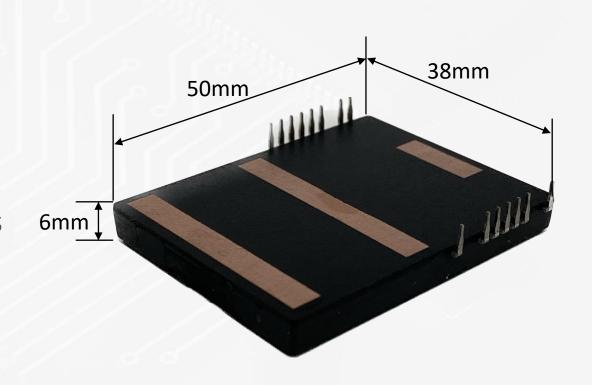


- Gate driver is directly driving the GaN Gate
- High Threshold Voltage margin: recommended VDD = 15V..20V, V_{TH} ≈ 8V
- Robust gate (compared to E-mode GaN technology)
- Designing a device that will reduce the constraints on the application designers.

D³GaN – Power Module VM044 Next iteration of D³GaN Power Module prototyping



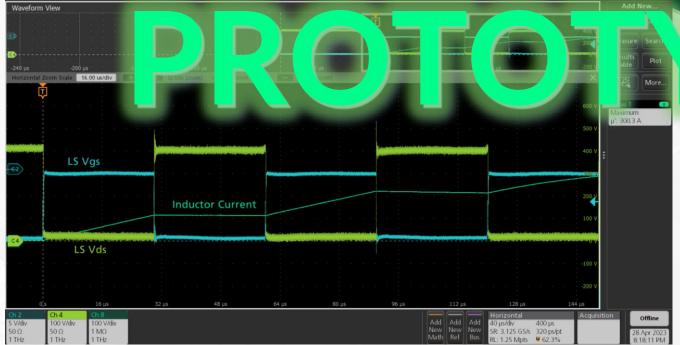
- $2x8m\Omega$, 650V parallel die
- Half Bridge configuration
- Transfer molded package
- Weldable power terminals = Low inductance terminal connection to busbars
- Thermal case designed for sintering to the heatsink = Lower thermal resistance
- High-performance Si3N4 ceramic substrate
- NTC sensor



D³GaN – Power Module VM044 EVB Next iteration

• VM044 Evaluation Board enables dynamic characterization and swift measurements of the povern department of the povern d

1st prototype testing: Multi-Pulse 400V, 300A







For further questions and in-depth technical discussion, visit us at booth **9-212**



mesago

pcim EUROPE

9 – 11.05.2023 NUREMBERG

Thank you for the attention!

I'm pleased to answer your questions in booth 9-212

This presentation is available on demand at PCIM Europe digital.

Messe Frankfurt Group



THANK YOU